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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/603,080	JAASKELA ET AL.	
Examiner	Art Unit	
Dustin Nguyen	2154	

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	SEARCHED			
Class	Subclass	Date	Examiner	
455	406, 407, 445, 432.1	3/1/2007	DN	
370	328, 352	3/1/2007	DN	
379	220.01	3/1/2007	DN	
709	223, 227	3/1/2007	DN	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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